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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.	
10/786,038	02/26/2004	Oh-Nam Kwon	8733.1014.00-US	2919	
30827 75	7590 06/30/2006 EXAMINER				
MCKENNA LONG & ALDRIDGE LLP			VU, D.	VU, DAVID	
1900 K STREET, NW WASHINGTON, DC 20006			ART UNIT	PAPER NUMBER	
			2818		
			DATE MAILED: 06/30/2006		

Please find below and/or attached an Office communication concerning this application or proceeding.

		Application No.	Applicant(s)	
		10/786,038	KWON, OH-NAM	
	Office Action Summary	Examiner	Art Unit	
		DAVID VU	2818	
Period fo	The MAILING DATE of this communication app	pears on the cover sheet with the c	orrespondence address	
A SHO WHIC - Exter after - If NO - Failu Any r	ORTENED STATUTORY PERIOD FOR REPLY CHEVER IS LONGER, FROM THE MAILING DA Issions of time may be available under the provisions of 37 CFR 1.1: SIX (6) MONTHS from the mailing date of this communication. Period for reply is specified above, the maximum statutory period v re to reply within the set or extended period for reply will, by statute eply received by the Office later than three months after the mailing and patent term adjustment. See 37 CFR 1.704(b).	ATE OF THIS COMMUNICATION 36(a). In no event, however, may a reply be tim will apply and will expire SIX (6) MONTHS from a cause the application to become ABANDONED	l. ely filed the mailing date of this communication. O (35 U.S.C. § 133).	
Status				
2a)	Responsive to communication(s) filed on <u>26 Fe</u> . This action is FINAL . 2b) This Since this application is in condition for alloware closed in accordance with the practice under E	action is non-final. nce except for formal matters, pro		
Dispositi	on of Claims			
5)□ 6)⊠ 7)□	Claim(s) <u>1-16</u> is/are pending in the application. 4a) Of the above claim(s) is/are withdraw Claim(s) is/are allowed. Claim(s) <u>1-16</u> is/are rejected. Claim(s) is/are objected to. Claim(s) are subject to restriction and/o	wn from consideration.		
Applicati	on Papers			
10)⊠	The specification is objected to by the Examine The drawing(s) filed on 26 February 2004 is/are Applicant may not request that any objection to the Replacement drawing sheet(s) including the correct The oath or declaration is objected to by the Example 2015.	e: a) accepted or b) objected drawing(s) be held in abeyance. See tion is required if the drawing(s) is obj	e 37 CFR 1.85(a). ected to. See 37 CFR 1.121(d).	
Priority u	ınder 35 U.S.C. § 119			
 12) Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f). a) All b) Some * c) None of: 1. Certified copies of the priority documents have been received. 2. Certified copies of the priority documents have been received in Application No 3. Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)). * See the attached detailed Office action for a list of the certified copies not received. 				
2) Notic 3) Inform	t(s) e of References Cited (PTO-892) e of Draftsperson's Patent Drawing Review (PTO-948) nation Disclosure Statement(s) (PTO-1449 or PTO/SB/08) r No(s)/Mail Date	4) Interview Summary Paper No(s)/Mail Da 5) Notice of Informal P 6) Other:		

DETAILED ACTION

Claim Rejections - 35 USC § 102

The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless -

(e) the invention was described in (1) an application for patent, published under section 122(b), by another filed in the United States before the invention by the applicant for patent or (2) a patent granted on an application for patent by another filed in the United States before the invention by the applicant for patent, except that an international application filed under the treaty defined in section 351(a) shall have the effects for purposes of this subsection of an application filed in the United States only if the international application designated the United States and was published under Article 21(2) of such treaty in the English language.

1. Claims 1-16 are rejected under 35 U. S. C. 102(e) as being anticipated by Tokuhiro et al. (US Pat. 6,548,831, hereinafter Tokuhiro).

Tokuhiro in figs. 1(b)-5(c) disclose a method of manufacturing a liquid crystal display device including a Mo/Cu electro line, comprising: forming a gate line 5 and a gate electrode 4, including: depositing a Mo/Cu layer on a substrate; forming a photoresist pattern on the gate line/gate electrode; etching the gate line/gate electrode Mo/Cu layer using either dry etching (plasma etching) (col. 4, lines 35-65) or wet-etching etchant to form a Mo/Cu electro line, wherein the photoresist pattern is used as a patterning mask; and removing Mo residue around the Mo/Cu electro line (fig. 1b); forming a gate insulating layer 6 on the gate line 5 and the gate electrode 4 (fig. 2 and col. 5, lines 5-10); forming a semiconductor layer 8 on the gate insulating layer 6 over the gate electrode 4 (col. 5, lines 17-21); forming a data line/a source/drain electrode 14 on the semiconductor layer 8 (col. 5, lines 45-49); forming a passivation layer on

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the data line, the source electrode and the drain electrode; and forming a pixel electrode (ITO) on the passivation layer (col. 6, lines 2-9). Note that, the wet etch using an etchant such as DI water, HF, HNO₃, aqueous solution containing water with hydrogen peroxide or the dry etch (plasma/ashing process) using oxygen radicals/ozone is well known in the art. Since the Mo residue is exposed to the wet/dry treatment, MoO₃ is formed. Therefore, removing the Mo residue around the Mo/Cu electro line includes oxidizing the Mo residue and removing the oxidized Mo residue.

Conclusion

2. Any inquiry concerning this communication or earlier communications from the examiner should be directed to David Vu whose telephone number is (571) 272-1798. The examiner can normally be reached on Monday-Friday from 8:00am to 5:00pm. If attempt to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Matthew Smith S can be reached on (571) 272-1907. The fax phone number for the organization where this application or proceeding is assigned is 703-872-9306.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR, Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

DAVID VU

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